## Application/Control No. Applicant(s)/Patent Under Reexamination 10/676,208 WEN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Edna Wong 1753 **U.S. PATENT DOCUMENTS** Document Number Date Name Classification Country Code-Number-Kind Code MM-YYYY US-6,534,863 03-2003 Walker et al. Α 257/737 \* US-2003/0176064 09-2003 438/687 В Lu et al. C US-US-D Ε US-F US-G US-Н US-USï US-USĸ US-L US-М **FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х